

Search Notes

Application/Control No.

10/668,225

Examiner

Christopher B. Shin

Applicant(s)/Patent under
Reexamination

ODAKURA ET AL.

Art Unit

2182

SEARCHED

Class	Subclass	Date	Examiner
710	52-57	6/20/2005	CBS
360	46,53,75	6/20/2005	CBS
711	202,218	6/20/2005	CBS
710	52-57	9/29/2005	CBS
710	58-60	9/29/2005	CBS
710	25	9/29/2005	CBS
710	33-35	9/29/2005	CBS
710	72-74	9/29/2005	CBS
370	232-234	9/29/2005	CBS

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
710	52,60,33	9/29/2005	CBS
710	25	9/29/2005	CBS
370	232	9/29/2005	CBS

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
PALM SEARCHED FOR DOUBLE PATNETING	6/17/2005	CBS
PLUS	6/21/2005	CBS
EAST (USPAT, USPGPUB, USPAT, EPO, JPO, DERWENT, IBMTDB, USOCR	6/20/2005	CBS
EAST (USPAT, USPGPUB, USPAT, EPO, JPO, DERWENT, IBMTDB, USOCR	9/29/2005	CBS
PALM SEARCHED FOR DOUBLE PATNETING	9/29/2005	CBS